30V DUAL N AND P-CHANNEL ENHANCEMENT MODE MOSFET

SUMMARY

N-CHANNEL: $V_{(BR)DSS}$ =30V; $R_{DS(ON)}$ =0.135 Ω ; I_D =2.3A P-CHANNEL: $V_{(BR)DSS}$ =-30V; $R_{DS(ON)}$ =0.185 Ω ; I_D =-2.0A

DESCRIPTION

This new generation of high density MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



MSOP8

FEATURES

- Low on-resistance
- · Fast switching speed
- · Low threshold
- · Low gate drive
- Low profile SOIC package

APPLICATIONS

- DC DC converters
- Power management functions

ORDERING INFORMATION

REEL SIZE

(inches)

7

13

TAPE WIDTH

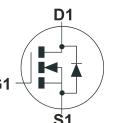
(mm)

12 embossed

12 embossed

- Disconnect switches
- Motor control

N-channel

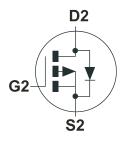


QUANTITY PER REEL

1,000

4,000

P-channel



 S1
 Θ
 ∞
 D1

 G1
 α
 Γ
 D1

 S2
 ω
 D2

 G2
 4
 ω
 D2

Pin-out

DEVICE MARKING

ZXMD63C03XTA

ZXMD63C03XTC

ZXM63C03

DEVICE

Top view



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain-Source Voltage	V _{DSS}	30	-30	V
Gate- Source Voltage	V _{GS}	±20		V
Continuous Drain Current $(V_{GS}=4.5V; T_A=25^{\circ}C)(b)(d)$ $(V_{GS}=4.5V; T_A=70^{\circ}C)(b)(d)$	I _D	2.3 1.8	-2.0 -1.6	A A
Pulsed Drain Current (c)(d)	I _{DM}	14	-9.6	А
Continuous Source Current (Body Diode)(b)(d)	Is	1.5	-1.4	А
Pulsed Source Current (Body Diode)(c)(d)	I _{SM}	14	-9.6	А
Power Dissipation at T _A =25°C (a)(d) Linear Derating Factor	P _D	0.87 6.9		W mW/°C
Power Dissipation at T _A =25°C (a)(e) Linear Derating Factor	P _D	1.04 8.3		W mW/°C
Power Dissipation at T _A =25°C (b)(d) Linear Derating Factor	P _D	1.25 10		W mW/°C
Operating and Storage Temperature Range	T _j :T _{stg}	-55 to +150		°C

THERMAL RESISTANCE

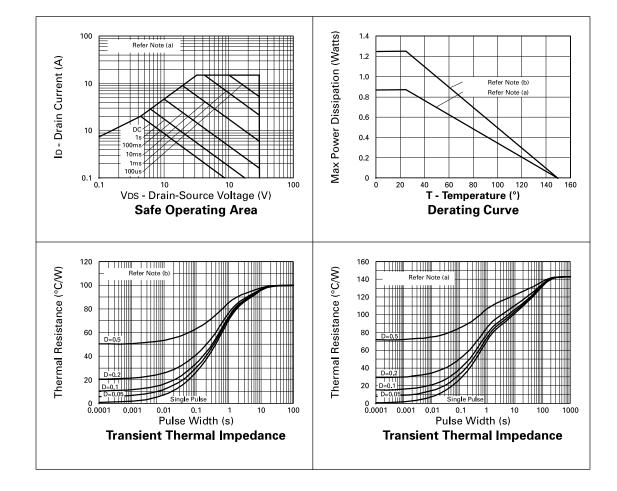
PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(d)	$R_{\theta JA}$	143	°C/W
Junction to Ambient (b)(d)	$R_{\theta JA}$	100	°C/W
Junction to Ambient (a)(e)	$R_{\theta JA}$	120	°C/W

NOTES:

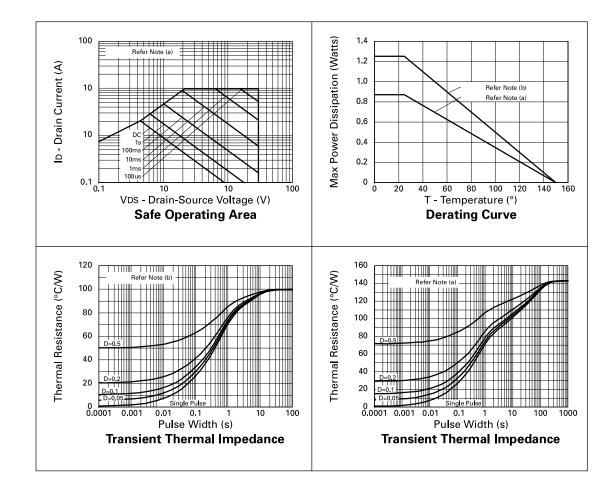
- (a) For a device surface mounted on 25 mm x 25 mm FR4 PCB with high coverage of single sided 1 oz copper, in still air conditions
- (b) For a device surface mounted on FR4 PCB measured at t≤10 secs.
- (c) Repetitive rating pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.
- (d) For device with one active die.
- (e) For device with two active die running at equal power.



N-CHANNEL CHARACTERISTICS



P-CHANNEL CHARACTERISTICS





N-CHANNEL ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^{\circ}C$ unless otherwise stated).

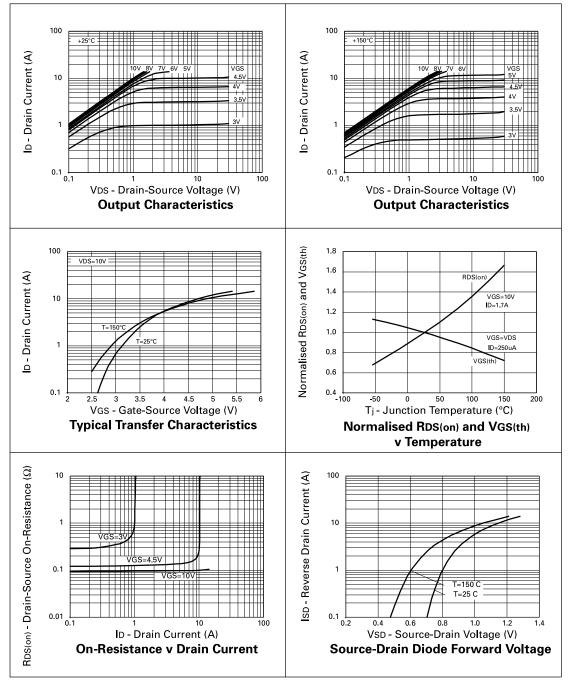
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS	
STATIC							
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	I _D =250μA, V _{GS} =0V	
Zero Gate Voltage Drain Current	I _{DSS}			1	μА	V _{DS} =30V, V _{GS} =0V	
Gate-Body Leakage	I _{GSS}			100	nA	V_{GS} = \pm 20V, V_{DS} =0V	
Gate-Source Threshold Voltage	V _{GS(th)}	1.0			V	I _D =250μA, V _{DS} = V _{GS}	
Static Drain-Source On-State Resistance (1)	R _{DS(on)}			0.135 0.200	Ω Ω	V _{GS} =10V, I _D =1.7A V _{GS} =4.5V, I _D =0.85A	
Forward Transconductance (3)	g _{fs}	1.9			s	V _{DS} =10V,I _D =0.85A	
DYNAMIC (3)							
Input Capacitance	C _{iss}		290		рF	V _{DS} =25 V, V _{GS} =0V, f=1MHz	
Output Capacitance	C _{oss}		70		рF		
Reverse Transfer Capacitance	C _{rss}		20		рF		
SWITCHING(2) (3)				•	-		
Turn-On Delay Time	t _{d(on)}		2.5		ns		
Rise Time	t _r		4.1		ns	V _{DD} =15V, I _D =1.7A	
Turn-Off Delay Time	t _{d(off)}		9.6		ns	$R_G=6.1\Omega$, $R_D=8.7\Omega$ (Refer to test circuit)	
Fall Time	t _f		4.4		ns		
Total Gate Charge	Q_g			8	nC	V _{DS} =24V,V _{GS} =10V, I _D =1.7A (Refer to test circuit)	
Gate-Source Charge	Q_{gs}			1.2	nC		
Gate Drain Charge	Q_{gd}			2	nC		
SOURCE-DRAIN DIODE				•	-		
Diode Forward Voltage (1)	V _{SD}			0.95	V	T _j =25°C, I _S =1.7A, V _{GS} =0V	
Reverse Recovery Time (3)	t _{rr}		16.9		ns	T _j =25°C, I _F =1.7A, di/dt= 100A/μs	
Reverse Recovery Charge(3)	Q _{rr}		9.5		nC		

NOTES

- (1) Measured under pulsed conditions. Width=300 μ s. Duty cycle \leq 2%.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.



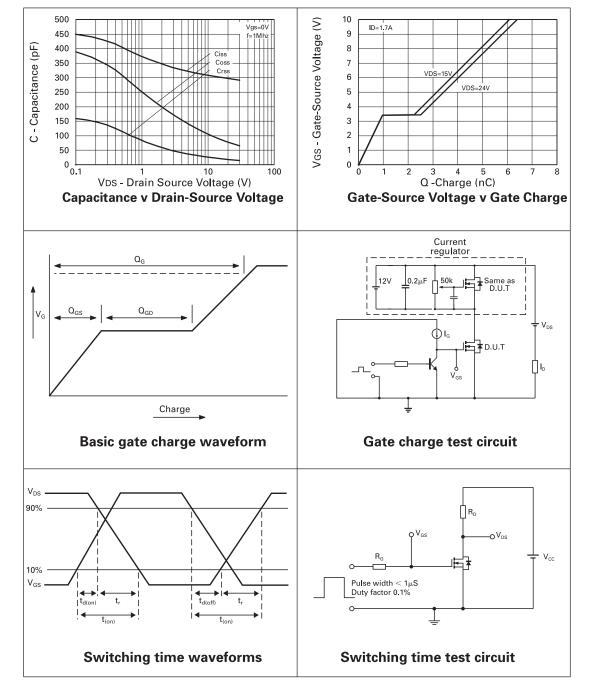
N-CHANNEL TYPICAL CHARACTERISTICS



ISSUE 2 - SEPTEMBER 2007



N-CHANNEL CHARACTERISTICS





P-CHANNEL ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated).

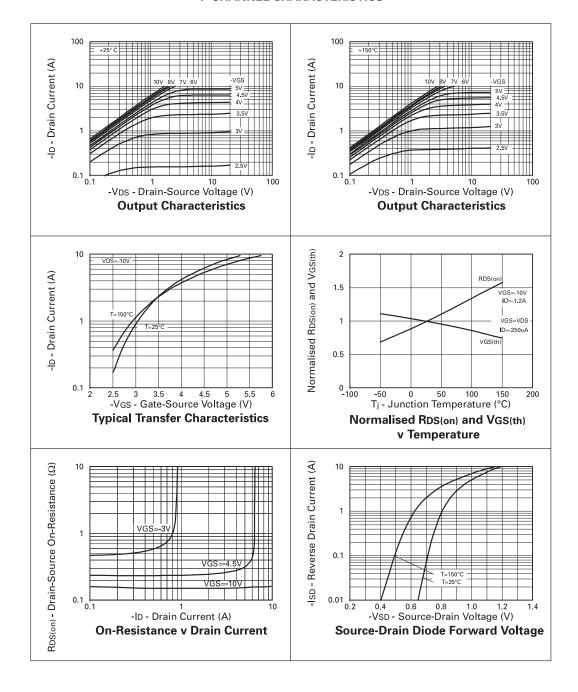
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS	
STATIC	•					•	
Drain-Source Breakdown Voltage	V _{(BR)DSS}	-30			٧	I _D =-250μA, V _{GS} =0V	
Zero Gate Voltage Drain Current	I _{DSS}			-1	μА	V _{DS} =-30V, V _{GS} =0V	
Gate-Body Leakage	I _{GSS}			±100	nA	V_{GS} = $\pm 20V$, V_{DS} = $0V$	
Gate-Source Threshold Voltage	V _{GS(th)}	-1.0			٧	$I_D = -250 \mu A, V_{DS} = V_{GS}$	
Static Drain-Source On-State Resistance (1)	R _{DS(on)}			0.185 0.27	Ω	V _{GS} =-10V, I _D =-1.2A V _{GS} =-4.5V, I _D =-0.6A	
Forward Transconductance (3)	9 _{fs}	0.92			S	V _{DS} =-10V,I _D =-0.6A	
DYNAMIC (3)						-	
Input Capacitance	C _{iss}		270		pF	V 25 V V 2V	
Output Capacitance	C _{oss}		80		pF	V _{DS} =-25 V, V _{GS} =0V, f=1MHz	
Reverse Transfer Capacitance	C _{rss}		30		pF	1	
SWITCHING(2) (3)						-	
Turn-On Delay Time	t _{d(on)}		2.6		ns		
Rise Time	t _r		4.8		ns	V _{DD} =-15V, I _D =-1.2A	
Turn-Off Delay Time	t _{d(off)}		13.1		ns	$R_G=6.2\Omega$, $R_D=6.2\Omega$ (Refer to test circuit)	
Fall Time	t _f		9.3		ns		
Total Gate Charge	Qg			7	nC		
Gate-Source Charge	Q _{gs}			1.2	nC	V _{DS} =-24V,V _{GS} =-10V, I _D =-1.2A	
Gate Drain Charge	Q_{gd}			2	nC	(Refer to test circuit)	
SOURCE-DRAIN DIODE							
Diode Forward Voltage (1)	V _{SD}			-0.95	V	T _j =25°C, I _S =-1.2A, V _{GS} =0V	
Reverse Recovery Time (3)	t _{rr}		21.4		ns	T _i =25°C, I _F =-1.2A, di/dt= 100A/μs	
Reverse Recovery Charge(3)	O _{rr}		15.7		nC		

NOTES

- (1) Measured under pulsed conditions. Width=300 $\mu s.$ Duty cycle ${\le}2\%$.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.

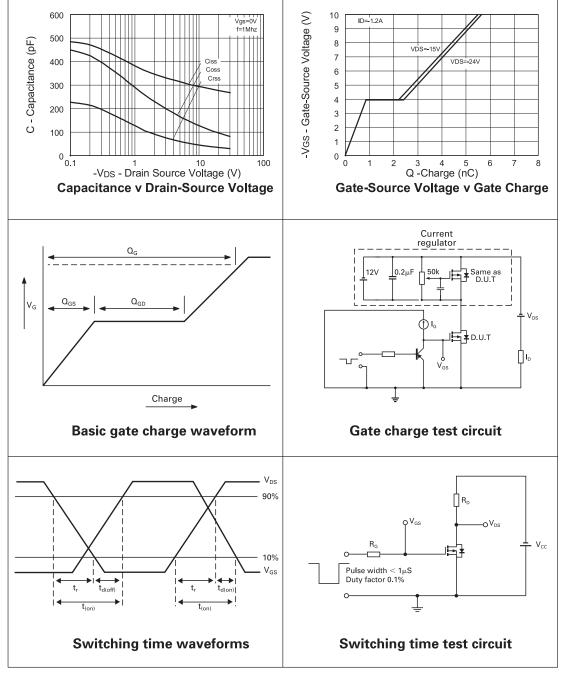


P-CHANNEL CHARACTERISTICS

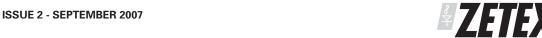




P-CHANNEL TYPICAL CHARACTERISTICS



Α



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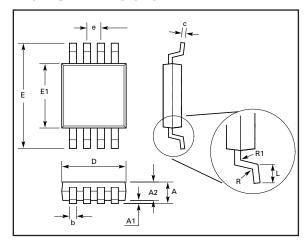
"Provisional version"This term denotes a pre-release datasheet. It provides a clear indication of anticipated performance. However, changes to the test conditions and specifications may occur, at any time and without notice.

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0.023

PACKAGE DIMENSIONS



1.02		
	4.8 0.189	
0.41	}	mm inches
$\left \begin{array}{c} 0.41 \\ \hline 0.016 \end{array} \right \left \begin{array}{c} - \\ - \end{array} \right $	$\frac{0.65}{0.033}$	

PAD LAYOUT DETAILS

DIM	Millimeters		Inches		
	Min.	Max.	Min.	Max.	
Α	-	1.10	-	0.0433	
A1	0.05	0.15	0.002	0.006	
A2	0.75	0.95	0.0295	0.0374	
b	0.25	0.40	0.010	0.0157	
С	0.13	0.23	0.005	0.009	
D	2.90	3.10	0.114	0.122	
Е	4.90	4.90 BSC		BSC	
E1	2.90	3.10	0.114	0.122	
е	0.65 BSC		0.025 BSC		
L	0.40	0.70	0.0157	0.0192	
R	0.07	-	0.0027	-	
R1	0.07	-	0.0027	-	

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